Application/Control No. Applicant(s)/Patent Under Reexamination 09/893,965 KIM ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Edgardo Ortiz 2815 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-Α В US-C US-D US-Ε US-F US-US-G US-Н US-US-J Κ US-L US-М US-FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY KR 2002071643 A 09-2002 Korea, Republic HWANG et al. G02F 01/136 Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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